Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/618,320	TAKAHASHI ET AL	
Examiner	Art Unit	
John D. Illm	1649	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
DC Buba D	eto Dandina		
Aps, SEQ II	ats, Pending D NO:1, a.a. 126	12/13/2007	JDU
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SEARCH NOT (INCLUDING SEARCH))
	DATE	EXMR
Updated + searched inventor names in NPL & PALM	1/8/2007	JDU
Updated	9/6/2007	JÒU
Updated	12/13/2007	JDU
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